

Notice of References Cited	Application/Control No. 10/050,627	Applicant(s)/Patent Under Reexamination YEN ET AL.	
	Examiner NABIL Z HINDI	Art Unit 2655	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,067,284	05-2000	Ikeda et al.	369/116
	B	US-6,459,666	10-2002	Yokoi, Kenya	369/47.15
	C	US-6,078,559	06-2000	Takemura et al.	369/275.3
	D	US-6,795,381	09-2004	Ando et al.	369/30.03
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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